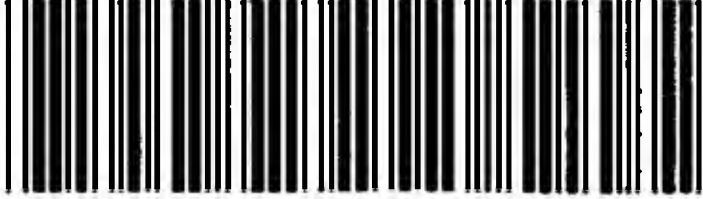


<div> <div>Search Notes</div>  </div>	<div>Application/Control No.</div> <div>10718305</div>	<div>Applicant(s)/Patent Under Reexamination</div> <div>NGUYEN ET AL.</div>
	<div>Examiner</div> <div>Keefer, Michael E</div>	<div>Art Unit</div> <div>2154</div>

SEARCHED			
Class	Subclass	Date	Examiner
709	203 (updated 1/9/2008)	7/10/2007	MEK
709	206 (text limited) (updated 1/9/2008)	7/11/2007	MEK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search	7/11/2007	MEK
Consulted Examiner Ashok Patel	7/10/2007	MEK
EAST Search	1/9/2008	MEK
Consulted Examiner Joshua Joo	1/9/2008	MEK
Consulted Examiner Hassan Phillips	1/9/2008	MEK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner